Sea	irch	Note	es

Application/Control No.	Applicant(s)/Patent u Reexamination	ınder
09/725,674	HIRANO ET AL.	
Examiner	Art Unit	-
Minh Dieu Nguyen	2137	

SEARCHED			
Class	Subclass	Date	Examiner
713	176-179, 201	6/8/2005	MDN
705	51	6/8/2005	MDN

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
713	176, 201	6/8/2005	MDN	
705	51	6/8/2005	MDN	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor name search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	6/8/2005	MDN		
EAST search (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	6/8/2005	MDN		